



# VN750SM

## HIGH SIDE DRIVER

PRELIMINARY DATA

TYPE	$R_{DS(on)}$	$I_{OUT}$	$V_{CC}$
VN750SM	55 mΩ	6 A	36 V

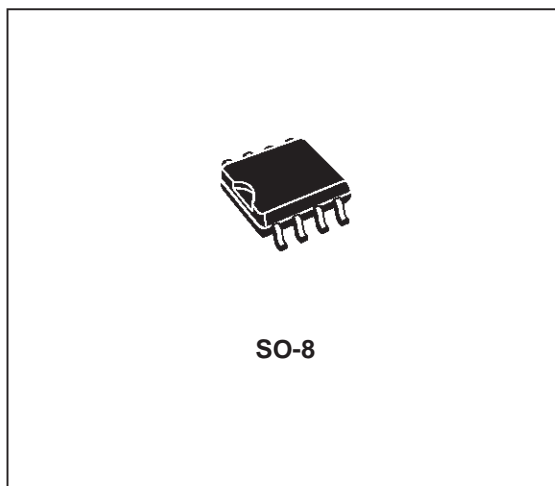
- CMOS COMPATIBLE INPUT
- ON STATE OPEN LOAD DETECTION
- OFF STATE OPEN LOAD DETECTION
- SHORTED LOAD PROTECTION
- UNDERVOLTAGE AND OVERVOLTAGE SHUTDOWN
- PROTECTION AGAINST LOSS OF GROUND
- VERY LOW STAND-BY CURRENT
- REVERSE BATTERY PROTECTION (\*)

### DESCRIPTION

The VN750SM is a monolithic device designed in STMicroelectronics VIPower M0-3 Technology, intended for driving any kind of load with one side connected to ground.

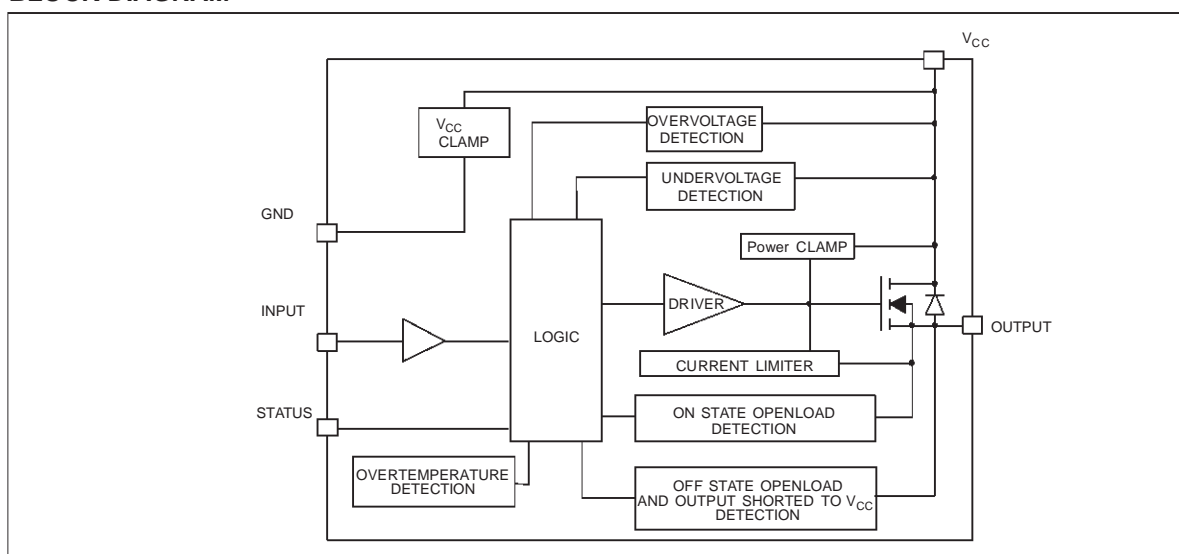
Active  $V_{CC}$  pin voltage clamp protects the device against low energy spikes (see ISO7637 transient compatibility table). Active current limitation combined with thermal shutdown and automatic restart protect the device against overload.

The device detects open load condition both in on and off state. The openload threshold is aimed at



detecting the 5W/12V standard bulb as an openload fault in the on state. Output shorted to  $V_{CC}$  is detected in the off state. Device automatically turns off in case of ground pin disconnection.

### BLOCK DIAGRAM

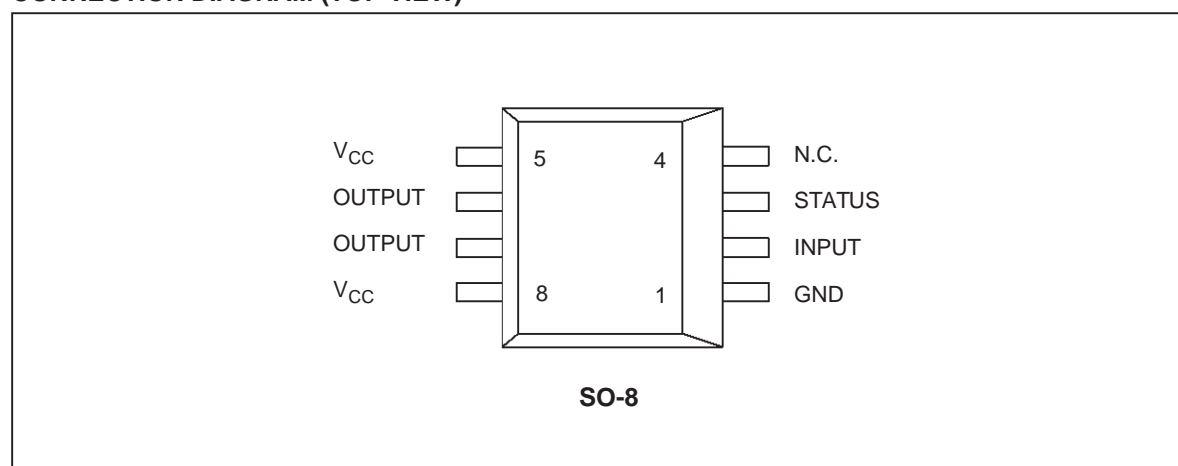


(\*) See application schematic at page 8

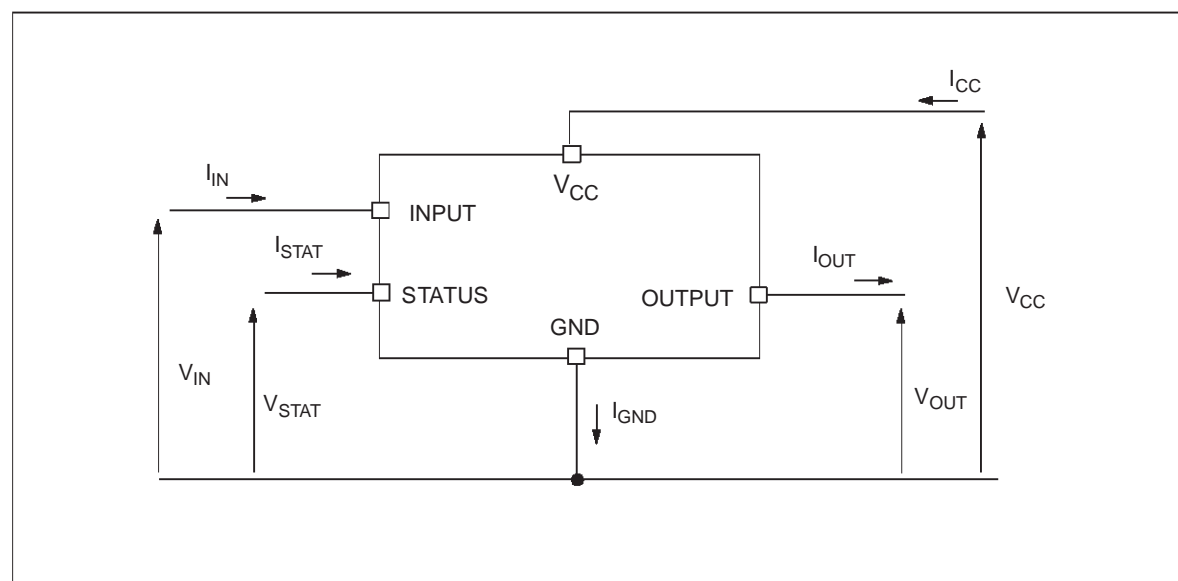
# ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Value	Unit
$V_{CC}$	DC Supply Voltage	41	V
$-V_{CC}$	Reverse DC Supply Voltage	- 0.3	V
$-I_{gnd}$	DC Reverse Ground Pin Current	- 200	mA
$I_{OUT}$	DC Output Current	Internally Limited	A
$-I_{OUT}$	Reverse DC Output Current	- 6	A
$I_{IN}$	DC Input Current	+/- 10	mA
$I_{STAT}$	DC Status Current	+/- 10	mA
$V_{ESD}$	Electrostatic Discharge (R=1.5K $\Omega$ ; C= 100 pF)	2000	V
$P_{tot}$	Power Dissipation $T_C=25^{\circ}C$	4.2	W
$T_j$	Junction Operating Temperature	Internally Limited	$^{\circ}C$
$T_{stg}$	Storage Temperature	- 55 to 150	$^{\circ}C$

# CONNECTION DIAGRAM (TOP VIEW)



# CURRENT AND VOLTAGE CONVENTIONS



## THERMAL DATA

Symbol	Parameter	Value	Unit
$R_{thj-lead}$	Thermal Resistance Junction-lead	Max 30	°C/W
$R_{thj-amb}$	Thermal Resistance Junction-ambient	Max 80 (*)	°C/W

(\*) When mounted on a standard single-sided FR-4 board with 50mm<sup>2</sup> of Cu (at least 35μm thick) connected to all V<sub>CC</sub> pins.

ELECTRICAL CHARACTERISTICS (8V<V<sub>CC</sub><36V; -40°C<T<sub>j</sub><150°C unless otherwise specified)

## POWER

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>CC</sub>	Operating Supply Voltage		5.5	13	36	V
V <sub>USD</sub>	Undervoltage Shut-down		3	4	5.5	V
V <sub>USDhyst</sub>	Undervoltage Shut-down Hysteresis			0.5		V
V <sub>OV</sub>	Overvoltage Shut-down		36	42	48	V
R <sub>ON</sub>	On State Resistance	I <sub>OUT</sub> =2A; T <sub>j</sub> =25°C; V <sub>CC</sub> >8V			55	mΩ
		I <sub>OUT</sub> =2A; V <sub>CC</sub> >8V			110	mΩ
I <sub>S</sub>	Supply Current	Off State; V <sub>CC</sub> =13V; V <sub>IN</sub> =V <sub>OUT</sub> =0V		10	25	μA
		Off State; V <sub>CC</sub> =13V; V <sub>IN</sub> =V <sub>OUT</sub> =0V; T <sub>j</sub> =25°C		10	20	μA
		On State; V <sub>CC</sub> =13V; V <sub>IN</sub> =5V; I <sub>OUT</sub> =0A		2	3.5	mA
I <sub>L(off1)</sub>	Off State Output Current	V <sub>IN</sub> =V <sub>OUT</sub> =0V	0		50	μA
I <sub>L(off2)</sub>	Off State Output Current	V <sub>IN</sub> =0V; V <sub>OUT</sub> =3.5V	-75		0	μA

SWITCHING (V<sub>CC</sub>=13V)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
t <sub>d(on)</sub>	Turn-on Delay Time	R <sub>L</sub> =6.5Ω from V <sub>IN</sub> rising edge to V <sub>OUT</sub> =1.3V		40		μs
t <sub>d(off)</sub>	Turn-off Delay Time	R <sub>L</sub> =6.5Ω from V <sub>IN</sub> falling edge to V <sub>OUT</sub> =11.7V		30		μs
dV <sub>OUT</sub> /dt <sub>(on)</sub>	Turn-on Voltage Slope	R <sub>L</sub> =6.5Ω from V <sub>OUT</sub> =1.3V to V <sub>OUT</sub> =10.4V		0.2		V/μs
dV <sub>OUT</sub> /dt <sub>(off)</sub>	Turn-off Voltage Slope	R <sub>L</sub> =6.5Ω from V <sub>OUT</sub> =11.7V to V <sub>OUT</sub> =1.3V		0.2		V/μs

## INPUT PIN

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>IL</sub>	Input Low Level				1.25	V
I <sub>IL</sub>	Low Level Input Current	V <sub>IN</sub> =1.25V	1			μA
V <sub>IH</sub>	Input High Level		3.25			V
I <sub>IH</sub>	High Level Input Current	V <sub>IN</sub> =3.25V			10	μA
V <sub>I(hyst)</sub>	Input Hysteresis Voltage		0.5			V
V <sub>ICL</sub>	Input Clamp Voltage	I <sub>IN</sub> =1mA	6	6.8	8	V
		I <sub>IN</sub> =-1mA		-0.7		V

## VCC - OUTPUT DIODE

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>F</sub>	Forward on Voltage	-I <sub>OUT</sub> =2A; T <sub>j</sub> =150°C			0.6	V

**ELECTRICAL CHARACTERISTICS** (continued)

## STATUS PIN

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$V_{STAT}$	Status Low Output Voltage	$I_{STAT}=1.6mA$			0.5	V
$I_{LSTAT}$	Status Leakage Current	Normal Operation; $V_{STAT}=5V$			10	$\mu A$
$C_{STAT}$	Status Pin Input Capacitance	Normal Operation; $V_{STAT}=5V$			100	pF
$V_{SCL}$	Status Clamp Voltage	$I_{STAT}=1mA$	6	6.8	8	V
		$I_{STAT}=-1mA$		-0.7		V

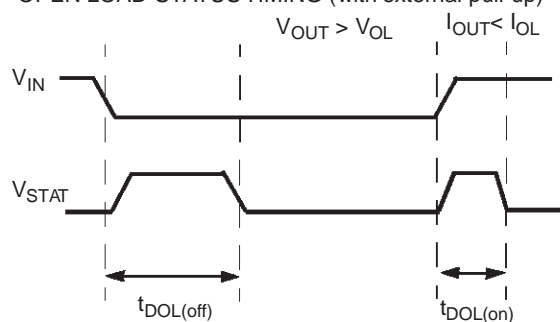
## PROTECTIONS

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$T_{TSD}$	Shut-down Temperature		150	175	200	$^{\circ}C$
$T_R$	Reset Temperature		135			$^{\circ}C$
$T_{hyst}$	Thermal Hysteresis		7	15		$^{\circ}C$
$t_{SDL}$	Status delay in overload condition	$T_j > T_{TSD}$			20	$\mu s$
$I_{lim}$	Current limitation	$5.5V < V_{CC} < 36V$	6	9	12	A
					12	A
$V_{demag}$	Turn-off Output Clamp Voltage	$I_{OUT}=2A$ ; $V_{IN}=0V$ ; $L=6mH$	$V_{CC}-41$	$V_{CC}-48$	$V_{CC}-55$	V

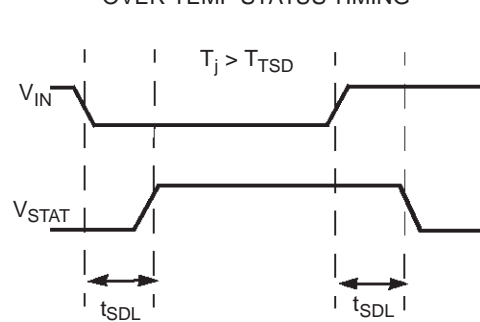
## OPENLOAD DETECTION

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$I_{OL}$	Openload ON State Detection Threshold	$V_{IN}=5V$	0.6	0.9	1.2	A
$t_{DOL(on)}$	Openload ON State Detection Delay	$I_{OUT}=0A$			200	$\mu s$
$V_{OL}$	Openload OFF State Voltage Detection Threshold	$V_{IN}=0V$	1.5	2.5	3.5	V
$t_{DOL(off)}$	Openload Detection Delay at Turn Off				1000	$\mu s$

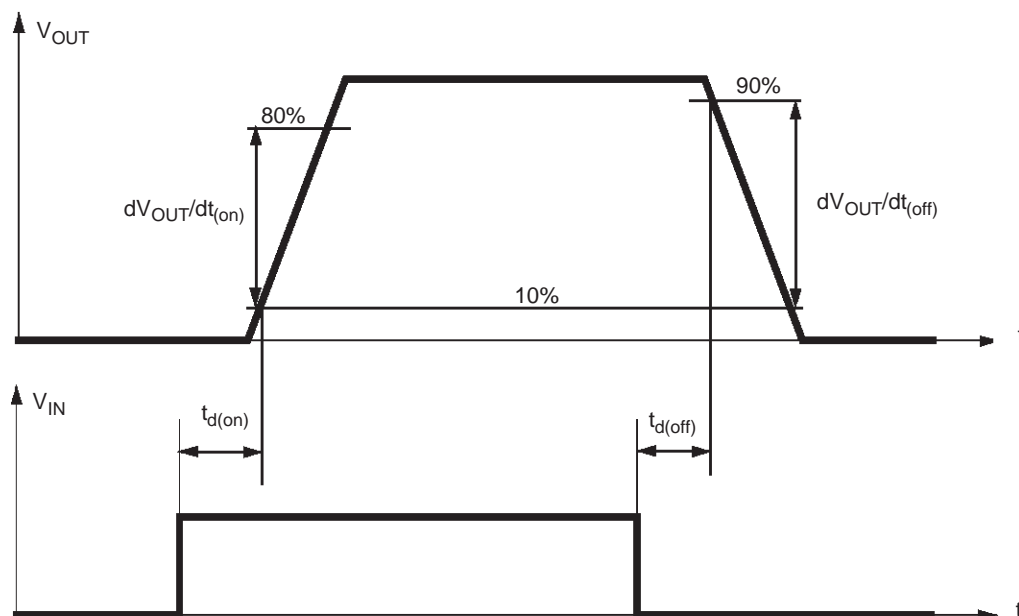
OPEN LOAD STATUS TIMING (with external pull-up)



OVER TEMP STATUS TIMING



## Switching time Waveforms



## TRUTH TABLE

CONDITIONS	INPUT	OUTPUT	STATUS
Normal Operation	L	L	H
	H	H	H
Current Limitation	L	L	H
	H	X	H
Overtemperature	L	L	H
	H	L	L
Undervoltage	L	L	X
	H	L	X
Overvoltage	L	L	H
	H	L	H
Output Voltage > $V_{OL}$	L	H	L
	H	H	H
Output Current < $I_{OL}$	L	L	H
	H	H	L

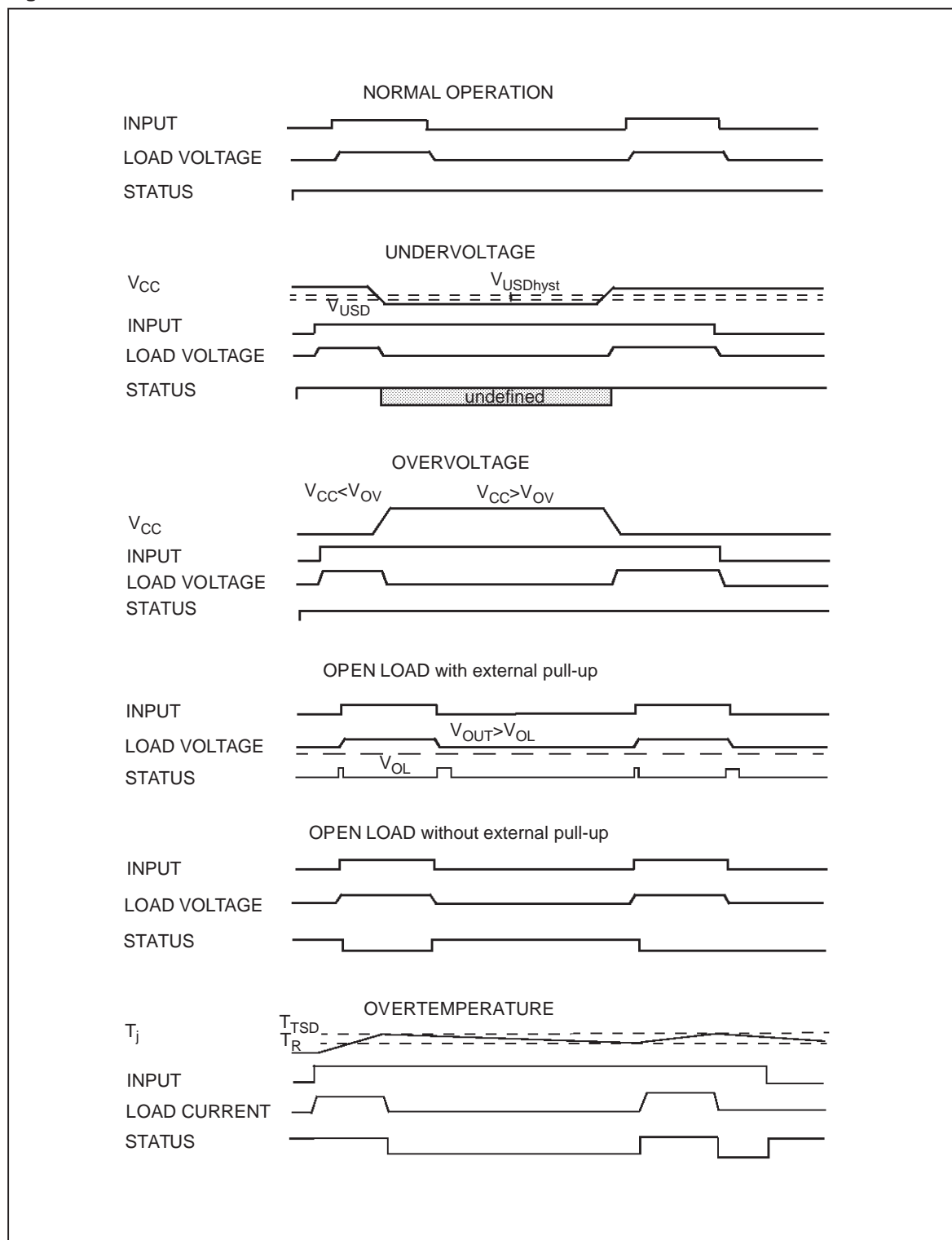
ELECTRICAL TRANSIENT REQUIREMENTS ON V<sub>CC</sub> PIN

ISO T/R 7637/1 Test Pulse	TEST LEVELS				Delays and Impedance
	I	II	III	IV	
1	-25 V	-50 V	-75 V	-100 V	2 ms 10 $\Omega$
2	+25 V	+50 V	+75 V	+100 V	0.2 ms 10 $\Omega$
3a	-25 V	-50 V	-100 V	-150 V	0.1 $\mu$ s 50 $\Omega$
3b	+25 V	+50 V	+75 V	+100 V	0.1 $\mu$ s 50 $\Omega$
4	-4 V	-5 V	-6 V	-7 V	100 ms, 0.01 $\Omega$
5	+26.5 V	+46.5 V	+66.5 V	+86.5 V	400 ms, 2 $\Omega$

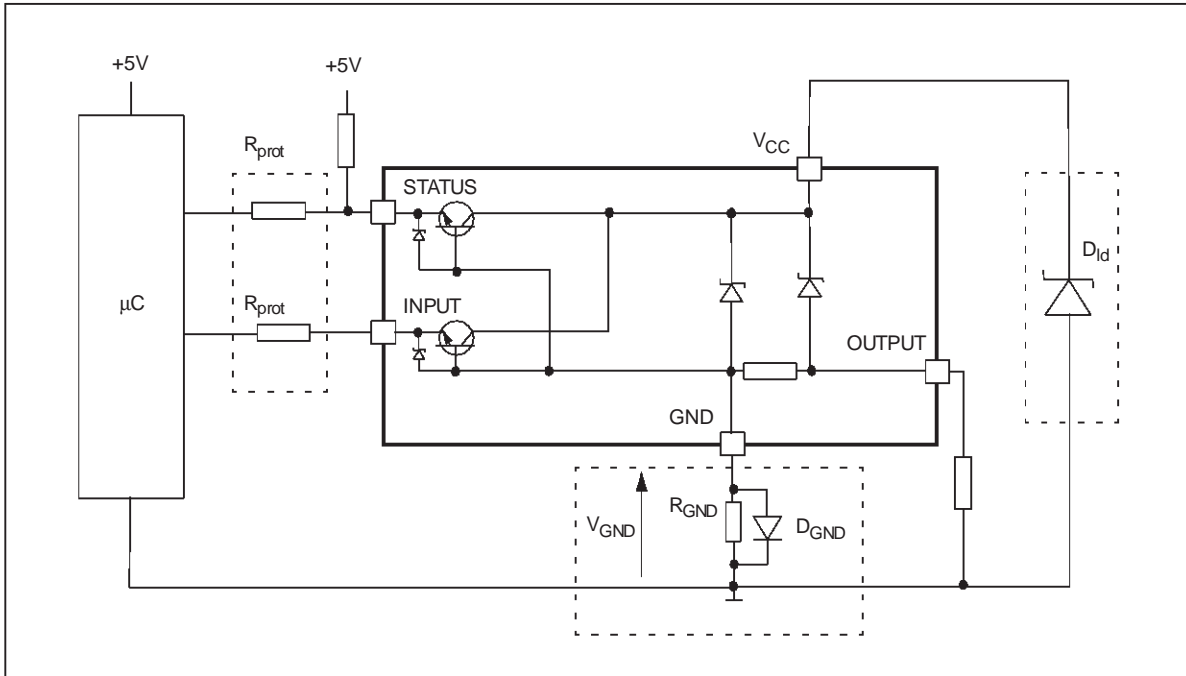
ISO T/R 7637/1 Test Pulse	TEST LEVELS RESULTS			
	I	II	III	IV
1	C	C	C	C
2	C	C	C	C
3a	C	C	C	C
3b	C	C	C	C
4	C	C	C	C
5	C	E	E	E

CLASS	CONTENTS
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device is not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device.

Figure1: Waveforms



## APPLICATION SCHEMATIC



## GND PROTECTION NETWORK AGAINST REVERSE BATTERY

**Solution 1:** Resistor in the ground line ( $R_{GND}$  only). This can be used with any type of load.

The following is an indication on how to dimension the  $R_{GND}$  resistor.

- 1)  $R_{GND} \leq 600\text{mV} / (I_{S(on)max})$ .
- 2)  $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where  $-I_{GND}$  is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device's datasheet.

Power Dissipation in  $R_{GND}$  (when  $V_{CC} < 0$ : during reverse battery situations) is:

$$P_D = (-V_{CC})^2 / R_{GND}$$

This resistor can be shared amongst several different HSD. Please note that the value of this resistor should be calculated with formula (1) where  $I_{S(on)max}$  becomes the sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not common with the device ground then the  $R_{GND}$  will produce a shift ( $I_{S(on)max} * R_{GND}$ ) in the input thresholds and the status output values. This shift will vary depending on how many devices are ON in the case of several high side drivers sharing the same  $R_{GND}$ .

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then the ST suggests to utilize Solution 2 (see below).

**Solution 2:** A diode ( $D_{GND}$ ) in the ground line.

A resistor ( $R_{GND} = 1\text{k}\Omega$ ) should be inserted in parallel to  $D_{GND}$  if the device will be driving an inductive load.

This small signal diode can be safely shared amongst several different HSD. Also in this case, the presence of the ground network will produce a shift (j 600mV) in the input threshold and the status output values if the microprocessor ground is not common with the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

## LOAD DUMP PROTECTION

$D_{id}$  is necessary (Transil or MOV) if the load dump peak voltage exceeds  $V_{CC}$  max DC rating. The same applies if the device will be subject to transients on the  $V_{CC}$  line that are greater than the ones shown in the ISO T/R 7637/1 table.

 $\mu\text{C}$  I/Os PROTECTION:

If a ground protection network is used and negative transients are present on the  $V_{CC}$  line, the control pins will be pulled negative. ST suggests to insert a resistor ( $R_{prot}$ ) in line to prevent the  $\mu\text{C}$  I/Os pins to latch-up.

The value of these resistors is a compromise between the leakage current of  $\mu\text{C}$  and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of  $\mu\text{C}$  I/Os.

$$-V_{CCpeak} / I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH} - V_{GND}) / I_{IHmax}$$

Calculation example:

For  $V_{CCpeak} = -100\text{V}$  and  $I_{latchup} \geq 20\text{mA}$ ;  $V_{OH\mu C} \geq 4.5\text{V}$

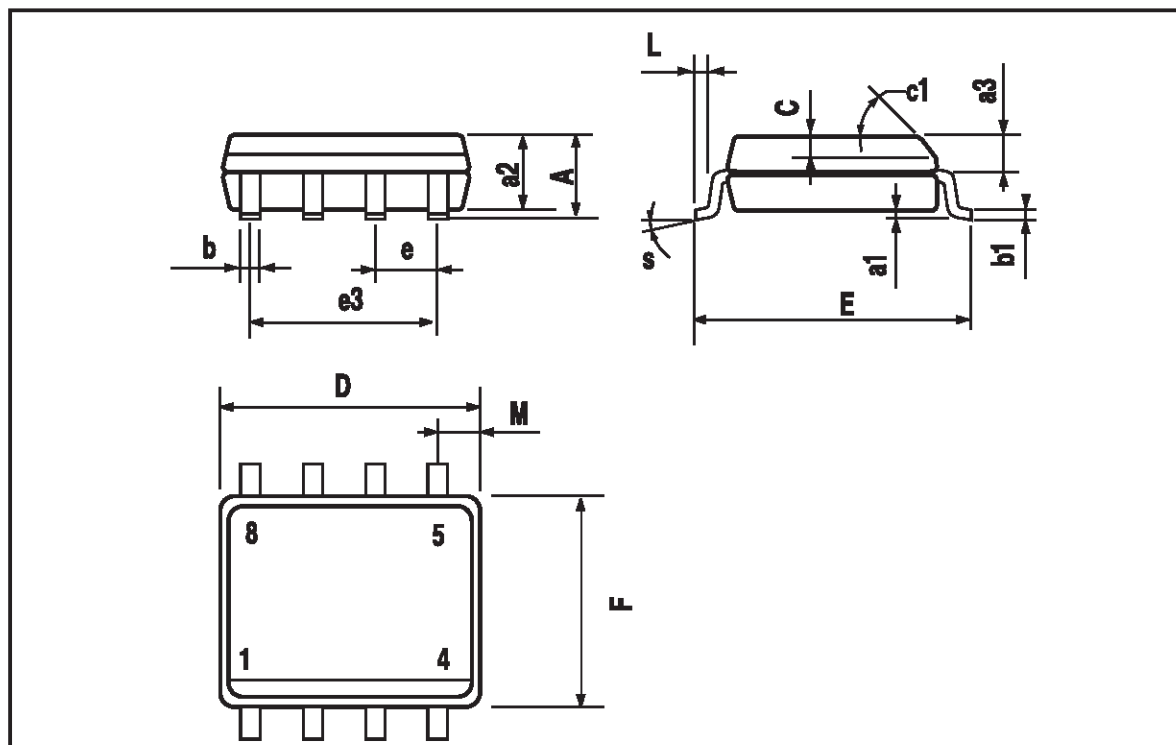
$$5\text{k}\Omega \leq R_{prot} \leq 65\text{k}\Omega$$

Recommended  $R_{prot}$  value is  $10\text{k}\Omega$ .

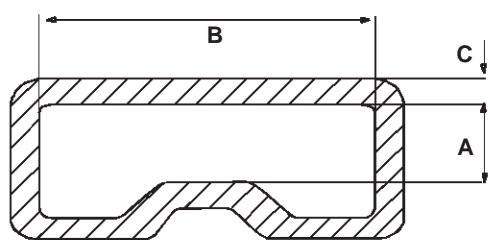


## SO-8 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
C	0.25		0.5	0.010		0.019
c1	45 (typ.)					
D	4.8		5	0.188		0.196
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
F	3.8		4	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
S	8 (max.)					
L1	0.8		1.2	0.031		0.047



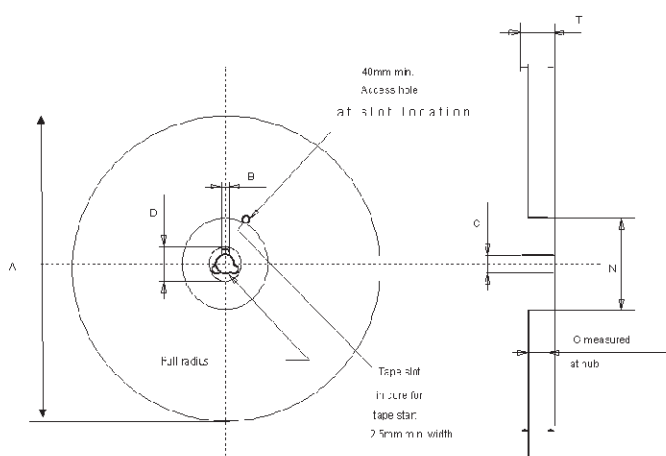
## SO-8 TUBE SHIPMENT (no suffix)



Base Q.ty	100
Bulk Q.ty	2000
Tube length ( $\pm 0.5$ )	532
A	3.2
B	6
C ( $\pm 0.1$ )	0.6

All dimensions are in mm.

## TAPE AND REEL SHIPMENT (suffix "13TR")



## REEL DIMENSIONS

Base Q.ty	2500
Bulk Q.ty	2500
A (max)	330
B (min)	1.5
C ( $\pm 0.2$ )	13
F	20.2
G (+2 / -0)	12.4
N (min)	60
T (max)	18.4

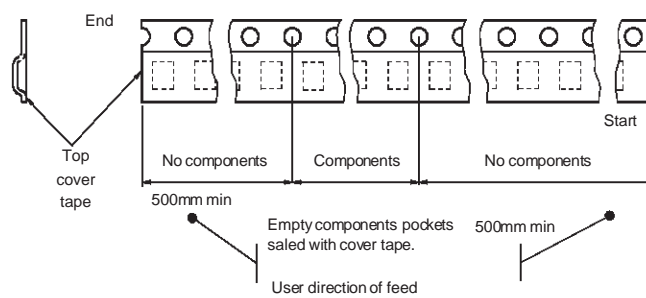
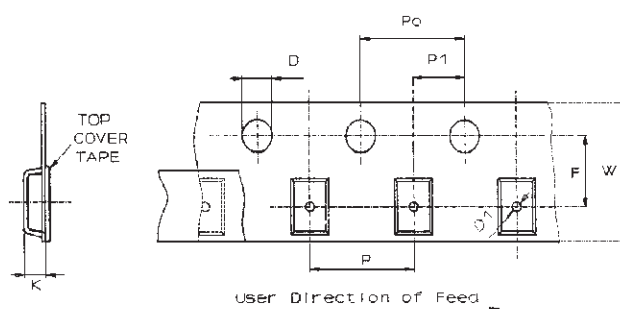
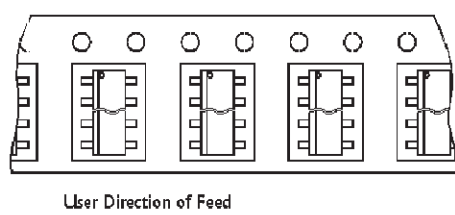
All dimensions are in mm.

## TAPE DIMENSIONS

According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb 1986

Tape width	W	12
Tape Hole Spacing	P0 ( $\pm 0.1$ )	4
Component Spacing	P	8
Hole Diameter	D ( $\pm 0.1/-0$ )	1.5
Hole Diameter	D1 (min)	1.5
Hole Position	F ( $\pm 0.05$ )	5.5
Compartment Depth	K (max)	4.5
Hole Spacing	P1 ( $\pm 0.1$ )	2

All dimensions are in mm.



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